INTEGRATED CIRCUITS

DATA SHEET

74ABT16543 74ABTH16543

16-bit latched transceivers with dual enable (3-State)

Product specification
Supersedes data of 1995 Aug 17
IC23 Data Handbook





16-bit latched transceivers with dual enable (3-State)

74ABT16543 74ABTH16543

FEATURES

- Two 8-bit octal transceivers with D-type latch
- Live insertion/extraction permitted
- Power-up 3-State
- Power-up reset
- Multiple V_{CC} and GND pins minimize switching noise
- Back-to-back registers for storage
- Separate controls for data flow in each direction
- 74ABTH16543 incorporates bus-hold data inputs which eliminate the need for external pull-up resistors to hold unused inputs
- Output capability: +64mA/-32mA
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model
- See 74ABT161543 for same function with Master Reset control pins

DESCRIPTION

The 74ABT16543 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT16543 16-bit registered transceiver contains two sets of D-type latches for temporary storage of data flowing in either direction. Separate Latch Enable (nLEAB, nLEBA) and Output Enable (nOEAB, nOEBA) inputs are provided for each register to permit independent control of data transfer in either direction. The outputs are guaranteed to sink 64mA.

Two options are available, 74ABT16543 which does not have the bus-hold feature and 74ABTH16543 which incorporates the bus-hold feature.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS T _{amb} = 25°C; GND = 0V	TYPICAL	UNIT
t _{PLH} t _{PHL}	Propagation delay nAx to nBx	$C_L = 50pF; V_{CC} = 5V$	2.5 2.2	ns
C _{IN}	Input capacitance	$V_I = 0V \text{ or } V_{CC}$	3	pF
C _{I/O}	I/O capacitance	V _O = 0V or V _{CC;} 3-State	7	pF
I _{CCZ}	Quiescent supply current	Outputs disabled; V _{CC} = 5.5V	550	μΑ
I _{CCL}	Quiescent supply current	Outputs low; V _{CC} = 5.5V	9	mA

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER	
56-Pin Plastic SSOP Type III	−40°C to +85°C	74ABT16543 DL	BT16543 DL	SOT371-1	
56-Pin Plastic TSSOP Type II	–40°C to +85°C	74ABT16543 DGG	BT16543 DGG	SOT364-1	
56-Pin Plastic SSOP Type III	-40°C to +85°C	74ABTH16543 DL	BH16543 DL	SOT371-1	
56-Pin Plastic TSSOP Type II	−40°C to +85°C	74ABTH16543 DGG	BH16543 DGG	SOT364-1	

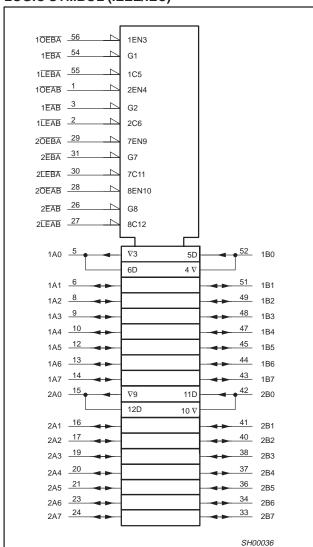
PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION			
5, 6, 8, 9, 10, 12, 13, 14 15, 16, 17, 19, 20, 21, 23, 24	1A0 – 1A7, 2A0 – 2A7	Data inputs/outputs			
52, 51, 49, 48, 47, 45, 44, 43 42, 41, 40,38, 37, 36, 34, 33	1B0 – 1B7, 2B0 – 2B7	Data inputs/outputs			
1, 56 28, 29	10EAB, 10EBA, 20EAB, 20EBA	A to B / B to A Output Enable inputs (active-Low)			
3, 54 26, 31	1EAB, 1EBA, 2EAB, 2EBA	A to B / B to A Enable inputs (active-Low)			
2, 55 27, 30	1LEAB, 1LEBA, 2LEAB, 2LEBA	A to B / B to A Latch Enable inputs (active-Low)			
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)			
7, 22, 35, 50	V _{CC}	Positive supply voltage			

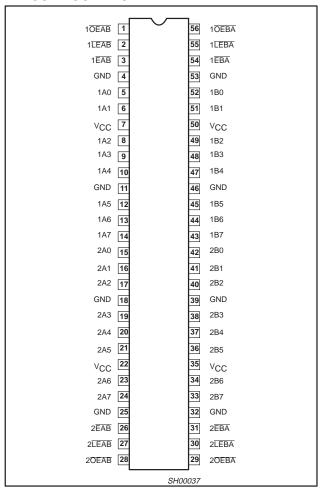
16-bit latched transceivers with dual enable (3-State)

74ABT16543 74ABTH16543

LOGIC SYMBOL (IEEE/IEC)



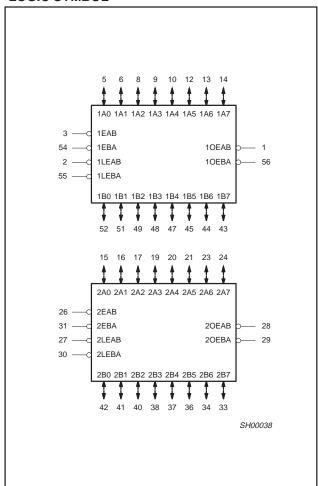
PIN CONFIGURATION



16-bit latched transceivers with dual enable (3-State)

74ABT16543 74ABTH16543

LOGIC SYMBOL



FUNCTIONAL DESCRIPTION

The 74ABT16543 contains two sets of eight D-type latches, with separate control pins for each set. Using data flow from A to B as an example, when the A-to-B Enable (nEAB) input and the A-to-B Latch Enable (nEAB) input are Low the A-to-B path is transparent.

A subsequent Low-to-High transition of the nLEAB signal puts the A data into the latches where it is stored and the B outputs no longer change with the A inputs. With EAB and nOEAB both Low, the 3-State B output buffers are active and display the data present at the outputs of the A latches.

Control of data flow from B to A is similar, but using the $n\overline{EBA}$, $n\overline{LEBA}$, and $n\overline{OEBA}$ inputs.

FUNCTION TABLE

	INI	PUTS		OUTPUTS	STATUS
nOEXX	nEXX	nLEXX	nAx or nBx	nBx or nAx	SIAIUS
Н	Х	Х	Х	Z	Disabled
Χ	Н	Х	Х	Z	Disabled
L L	<u>†</u>	L L	h I	Z Z	Disabled + Latch
L L	L L	↑	h I	H L	Latch + Display
L L	L L	L L	H L	H L	Transparent
L	L	Н	Х	NC	Hold

H = High voltage level

h = High voltage level one set-up time prior to the Low-to-High transition of nEXX or nEXX (XX = AB or BA)

L = Low voltage level

I = Low voltage level one set-up time prior to the Low-to-High transition of nEXX or nEXX (XX = AB or BA)

X = Don't care

 \uparrow = Low-to-High transition of n \overline{LEXX} or n \overline{EXX} (XX = AB or BA)

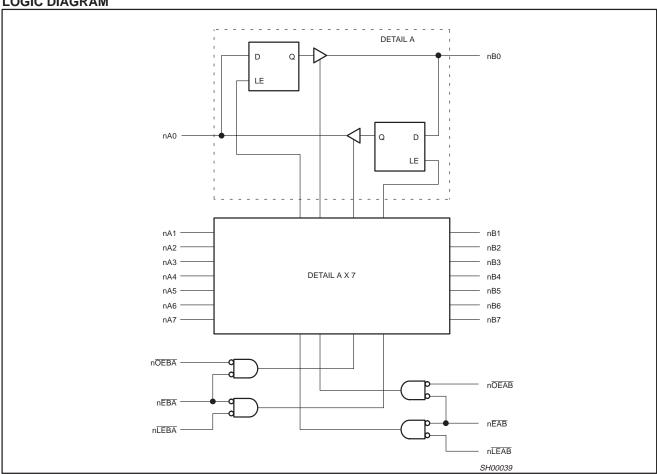
NC= No change

Z = High impedance or "off" state

16-bit latched transceivers with dual enable (3-State)

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LOGIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		−0.5 to +7.0	V
I _{IK}	DC input diode current	V _I < 0	-18	mA
VI	DC input voltage ³		-1.2 to +7.0	V
lok	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	output in Off or High state	-0.5 to +5.5	V
	DC output ourrent	output in Low state	128	mA
louт	DC output current	output in High state	-64	mA
T _{stg}	Storage temperature range		-65 to 150	°C

NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the
 device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

3. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

16-bit latched transceivers with dual enable (3-State)

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RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIM	UNIT	
STWIBOL	FARAMETER	Min	Max	ONIT
V _{CC}	DC supply voltage	4.5	5.5	V
VI	Input voltage	0	V _{CC}	V
V_{IH}	High-level input voltage	2.0		V
V_{IL}	Low-level Input voltage		0.8	V
I _{OH}	High-level output current		-32	mA
I _{OL}	Low-level output current		64	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

DC ELECTRICAL CHARACTERISTICS

						LIMITS			UNIT
SYMBOL	PARAMETER	TEST CONDITIONS		T _z	_{amb} = +25	°C	T _{amb} =	–40°C 35°C	
				MIN	TYP	MAX	MIN	MAX	1
V _{IK}	Input clamp voltage	$V_{CC} = 4.5V; I_{IK} = -18mA$				-1.2		-1.2	V
		$V_{CC} = 4.5V; I_{OH} = -3mA; V_{I} = V_{IL} c$	r V _{IH}	2.5	2.9		2.5		V
V_{OH}	High-level output voltage	$V_{CC} = 5.0V; I_{OH} = -3mA; V_{I} = V_{IL} c$	r V _{IH}	3.0	3.4		3.0		V
		$V_{CC} = 4.5V; I_{OH} = -32mA; V_I = V_{IL}$	or V _{IH}	2.0	2.4		2.0		V
V _{OL}	Low-level output voltage	$V_{CC} = 4.5V; I_{OL} = 64mA; V_{I} = V_{IL} o$	r V _{IH}		0.36	0.55		0.55	V
V _{RST}	Power-up output voltage ³	$V_{CC} = 5.5V; I_{O} = 1mA; V_{I} = GND or$	r V _{CC}		0.13	0.55		0.55	V
l ₁	Input leakage current	$V_{CC} = 5.5V$; $V_I = GND \text{ or } 5.5V$ Control pins			± 0.01	±1.0		±1.0	μА
		$V_{CC} = 4.5V; V_I = 0.8V$					35		
I _{HOLD}	Bus Hold current A or B Ports ⁵ 74ABTH16543	$V_{CC} = 4.5V; V_I = 2.0V$					-75		μΑ
	1 010 7 17 12 11 11 00 10	$V_{CC} = 5.5V$; $V_I = 0$ to $5.5V$		±800					1
I _{OFF}	Power-off leakage current	$V_{CC} = 0.0V$; V_O or $V_I \le 4.5V$			±2.0	±100		±100	μА
I _{PU/PD}	Power-up/down 3-State output current ⁴	V_{CC} = 2.1V; V_{O} = 0.0V or V_{CC} ; V_{I} = GND or V_{CC} ; V_{OE} = Don't care)		±1.0	±50		±50	μА
I _{IH} + I _{OZH}	3-State output High current	$V_{CC} = 5.5V; V_{O} = 5.5V; V_{I} = V_{IL} \text{ or }$	V _{IH}		1.0	10		10	μА
I _{IL} + I _{OZL}	3-State output Low current	$V_{CC} = 5.5V$; $V_{O} = 0.0V$; $V_{I} = V_{IL}$ or	V _{IH}		-1.0	-10		-10	μА
I _{CEX}	Output High leakage current	$V_{CC} = 5.5V$; $V_{O} = 5.5V$; $V_{I} = GND$ (or V _{CC}		1.0	50		50	μΑ
Io	Output current ¹	$V_{CC} = 5.5V; V_{O} = 2.5V$		-50	-100	-200	-50	-200	mA
I _{CCH}		$V_{CC} = 5.5V$; Outputs High, $V_I = GN$	D or V _{CC}		0.55	2		2	mA
I _{CCL}	Quiescent supply current	$V_{CC} = 5.5V$; Outputs Low, $V_I = GNI$	O or V _{CC}		9	19		19	mA
I _{CCZ}		V_{CC} = 5.5V; Outputs 3–State; V_{I} = GND or V_{CC}			0.55	2		2	mA
Δl _{CC}	Additional supply current per input pin ² 74ABT16543	V_{CC} = 5.5V; one input at 3.4V, other inputs at V_{CC} or GND		5.0	50		50	μА	
Δl _{CC}	Additional supply current per input pin ² 74ABTH16543	V_{CC} = 5.5V; one input at 3.4V, other inputs at V_{CC} or GND			200	500		500	μА

NOTES:

- 1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

- Not into that of output should be tested at a fine, and the dufation of the test should not exceed the second.
 This is the increase in supply current for each input at 3.4V.
 For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.
 This parameter is valid for any V_{CC} between 0V and 2.1V, with a transition time of up to 10msec. From V_{CC} = 2.1V to V_{CC} = 5V ± 10% a transition time of up to 100μsec is permitted.
 This is the bus hold overdrive current required to force the input to the opposite logic state.

16-bit latched transceivers with dual enable (3-State)

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AC CHARACTERISTICS

GND = 0V, t_R = t_F = 2.5ns, C_L = 50pF, R_L = 500 Ω

SYMBOL	PARAMETER	WAVEFORM		Γ _{amb} = +25° V _{CC} = +5.0\		T _{amb} = -4 V _{CC} = +5	UNIT	
			MIN	TYP	MAX	MIN	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nBx, nBx to nAx	2	1.0 1.0	2.5 2.2	3.3 4.4	1.0 1.0	3.8 5.1	ns
t _{PLH} t _{PHL}	Propagation delay LEBA to nAx, LEAB to nBx	1, 2	1.0 1.2	3.1 3.0	4.3 4.8	1.0 1.2	5.2 5.6	ns
t _{PZH} t _{PZL}	Output enable time OEBA to nAx, OEAB to nBx	4 5	1.0 1.1	3.3 3.3	4.3 5.9	1.0 1.1	5.2 7.0	ns
t _{PHZ} t _{PLZ}	Output disable time OEBA to nAx, OEAB to nBx	4 5	1.9 1.6	3.5 2.6	5.0 4.2	1.9 1.6	5.7 4.6	ns
t _{PZH} t _{PZL}	Output enable time EBA to nAx, EAB to nBx	4 5	1.0 1.2	3.4 3.4	4.9 6.5	1.0 1.2	6.2 7.8	ns
t _{PHZ}	Output disable time EBA to nAx, EAB to nBx	4 5	2.0 1.7	3.4 2.6	5.6 5.1	2.0 1.7	6.6 5.4	ns

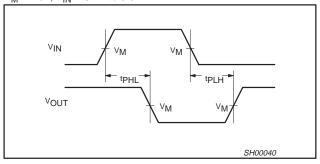
AC SETUP REQUIREMENTS

GND = 0V, t_R = t_F = 2.5ns, C_L = 50pF, R_L = 500 Ω

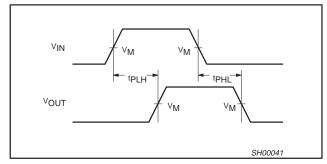
SYMBOL	PARAMETER	WAVEFORM		: +25°C : +5.0V	T _{amb} = -40 to +85°C V _{CC} = +5.0V ±0.5V	UNIT
			MIN	TYP	MIN	
$t_{s}(H)$ $t_{s}(L)$	Setup time nAx to LEAB, nBx to LEBA	3	1.5 3.5	0.4 -0.1	1.5 3.5	ns
t _h (H) t _h (L)	Hold time nAx to LEAB, nBx to LEBA	3	1.5 2.0	0.2 -0.3	1.5 2.0	ns
t _S (H) t _S (L)	Setup time nAx to EAB, nBx to EBA	3	1.5 3.5	0.2 -0.3	1.5 3.5	ns
t _h (H) t _h (L)	Hold time nAx to EAB, nBx to EBA	3	1.5 2.0	0.3 -0.2	1.5 2.0	ns
t _w (L)	Latch enable pulse width, Low	3	4.0	3.1	4.0	ns

AC WAVEFORMS

 $V_M = 1.5V$, $V_{IN} = GND$ to 3.0V



Waveform 1. Propagation Delay For Inverting Output



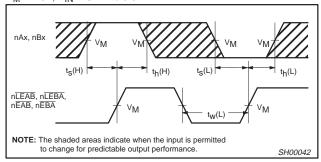
Waveform 2. Propagation Delay For Non-Inverting Output

16-bit latched transceivers with dual enable (3-State)

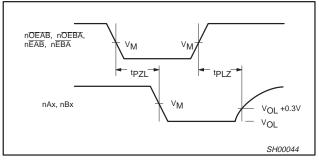
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AC WAVEFORMS (Continued)

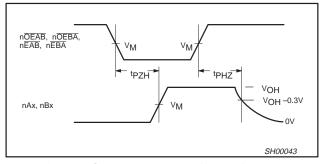
 $V_{M} = 1.5V, V_{IN} = GND \text{ to } 3.0V$



Waveform 3. Data Setup and Hold Times and Latch Enable
Pulse Width

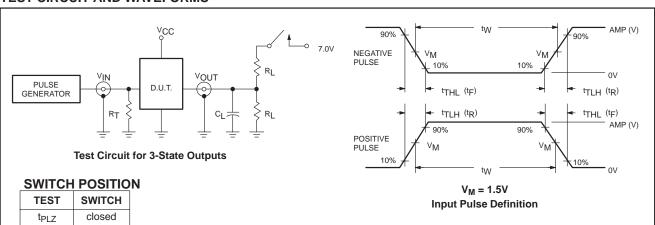


Waveform 5. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level



Waveform 4. 3-State Output Enable Time to High Level and Output Disable Time from High Level

TEST CIRCUIT AND WAVEFORMS



DEFINITIONS

closed

open

 t_{PZL}

All other

R_I = Load resistor; see AC CHARACTERISTICS for value.

C_L = Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value.

 R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.

FAMILY	IN	PUT PULSE R	EQUIRE	MENTS	
PAWILI	Amplitude	Rep. Rate	t _W	t _R	t _F
74ABT/H16	3.0V	1MHz	500ns	2.5ns	2.5ns

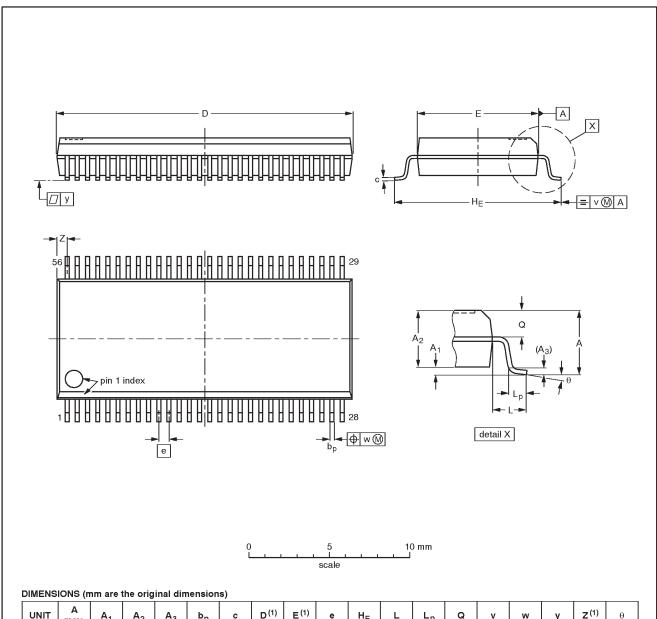
SA00018

16-bit latched transceivers with dual enable (3-State)

74ABT16543 74ABTH16543

SSOP56: plastic shrink small outline package; 56 leads; body width 7.5 mm

SOT371-1



	militarione (minute and original annoncerto)																	
UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	2.8	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	18.55 18.30	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT371-1		MO-118AB				93-11-02 95-02-04

16-bit latched transceivers with dual enable (3-State)

74ABT16543 74ABTH16543

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1mm

SOT364-1

144

13.9

10.1

SOT364-1

SOT364-1

10.5

SOT364-1

SOT

16-bit latched transceivers with dual enable (3-State)

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NOTES

16-bit latched transceivers with dual enable (3-State)

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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^[1] Please consult the most recently issued datasheet before initiating or completing a design.

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